

N and P-Channel Enhancement Mode Power MOSFET

Description

The HM4615 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge . The SOP-8 package is universally preferred for all commercial industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

General Features

N-Channel

 $V_{DS} = 100V, ID = 6.5A$

 $R_{DS(ON)} < 37 \text{m}\Omega$ @ VGS=10V (Typ:33m Ω)

P-Channel

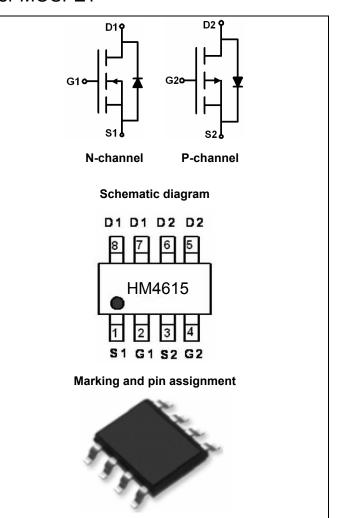
V_{DS} =100V,ID =-4.5A

 $R_{DS(ON)}$ <100m Ω @ VGS=-10V (Typ:85m Ω)

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- Battery protection
- Load switch
- Power management



SOP-8 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM4615	HM4615	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

3 ():						
Parameter		Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage		V _{DS}	100	-100	V	
Gate-Source Voltage		V _{GS}	±20	±20	V	
Continuous Drain Current	T _A =25℃	- I _D	6.5	-4.5	Δ.	
	T _A =70°C		4.6	-3.0	Α	
Pulsed Drain Current (Note 1)		I _{DM}	26	-18	А	
Maximum Power Dissipation	T _A =25℃	P _D	3	3	W	
Operating Junction and Storage Temperature Range		T_{J} , T_{STG}	-55 To 150	-55 To 150	$^{\circ}$ C	



Thermal Characteristic

Thermal Resistance.Junction-to-Ambient (Note2)	$R_{ hetaJA}$	N-Ch	50	°C/W	
Thermal Nesistance, Junction-to-Ambient (Note2)		P-Ch	50	CIVV	

N-CH Electrical Characteristics (T_A=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	<u> </u>					
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA		110	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)	•					
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	3.3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =6.5A	-	33	37	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =6.5A	20	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C _{lss}	\/ -50\/\/ -0\/	-	2000	-	PF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V, F=1.0MHz	-	300	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIHZ	-	250	-	PF
Switching Characteristics (Note 4)				Į.		
Turn-on Delay Time	t _{d(on)}		-	12	-	nS
Turn-on Rise Time	t _r	V_{DD} =50V, I_{D} =6.5A, R_{L} =5 Ω ,	-	10	-	nS
Turn-Off Delay Time	$t_{d(off)}$	$R_G=1\Omega,V_{GS}=10V$	-	19	-	nS
Turn-Off Fall Time	t _f		-	8	-	nS
Total Gate Charge	Qg		-	42	-	nC
Gate-Source Charge	Q _{gs}	I _D =6.5A,V _{DD} =50V,V _{GS} =10V	-	9	-	nC
Gate-Drain Charge	Q_{gd}		-	10	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =6.5A	-	0.85	1.2	V
Diode Forward Current (Note 2)	I _S		-	-	6.5	Α
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F = 6.5A	-	30		nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	44		nC



P-CH Electrical Characteristics (T_A=25 $^{\circ}$ Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit		
Off Characteristics								
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-100	-	-	V		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-100V,V _{GS} =0V	-	-	1	μΑ		
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±20	μΑ		
On Characteristics (Note 3)								
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-1	-1.9	-3	V		
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-4.5A	-	85	100	mΩ		
Forward Transconductance	g FS	V _{DS} =-50V,I _D =-4.5A	5	-	-	S		
Dynamic Characteristics (Note4)								
Input Capacitance	C _{lss})/ 05)/)/ 0)/	-	2100	-	PF		
Output Capacitance	Coss	V_{DS} =-25V, V_{GS} =0V, F=1.0MHz	-	590	-	PF		
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIHZ	-	140	-	PF		
Switching Characteristics (Note 4)								
Turn-on Delay Time	t _{d(on)}		-	16	-	nS		
Turn-on Rise Time	t _r	V _{DD} =-50V,I _D =-4.5A	-	73	-	nS		
Turn-Off Delay Time	$t_{\sf d(off)}$	V_{GS} =-10V, R_{GEN} =9.1 Ω	-	34	-	nS		
Turn-Off Fall Time	t _f		-	57	-	nS		
Total Gate Charge	Qg	\/ - 00\/ I - 4.5A	-	61	-	nC		
Gate-Source Charge	Q _{gs}	V _{DS} =-80V,I _D =-4.5A, V _{GS} =-10V	-	14	-	nC		
Gate-Drain Charge	Q _{gd}	V _{GS} =-10V	-	29	-	nC		
Drain-Source Diode Characteristics								
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-4.5A	-	-	-1.2	V		
Diode Forward Current (Note 2)	Is	-	-	-	-4.5	Α		
Reverse Recovery Time	t _{rr}	TJ = 25°C, IF =-4.5A	-	88.3	-	nS		
Reverse Recovery Charge	Qrr	di/dt = 100A/µs(Note3) - 65.9 - n						
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)						

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production

N- Channel Typical Electrical and Thermal Characteristics (Curves)

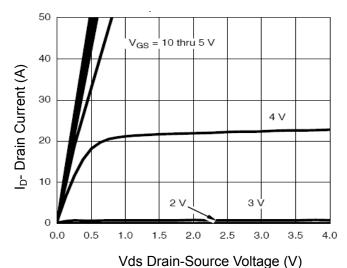


Figure 1 Output Characteristics

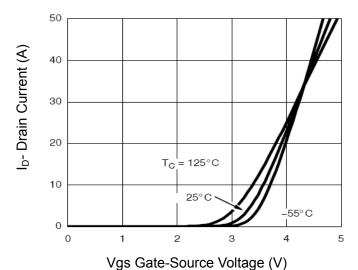


Figure 2 Transfer Characteristics

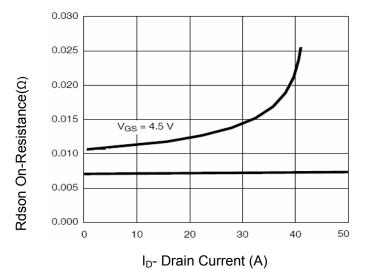


Figure 3 Rdson- Drain Current

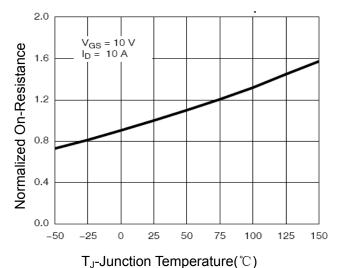


Figure 4 Rdson- Junction Temperature

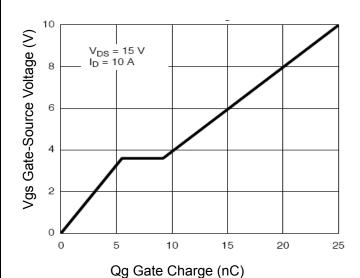


Figure 5 Gate Charge

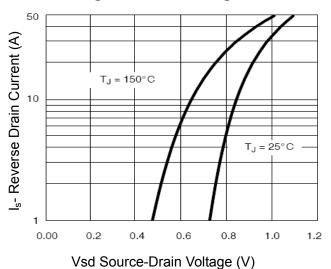


Figure 6 Source- Drain Diode Forward



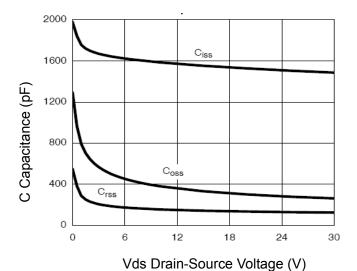
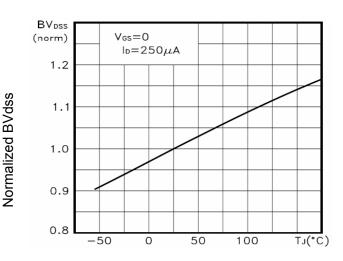
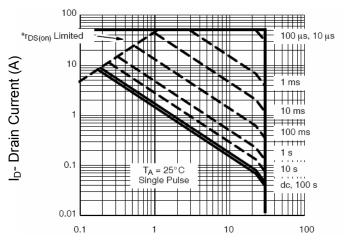


Figure 7 Capacitance vs Vds

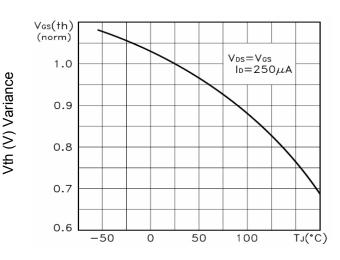


 T_J -Junction Temperature (°C) Figure 9 BV_{DSS} vs Junction Temperature



Vds Drain-Source Voltage (V)

Figure 8 Safe Operation Area



T_J-Junction Temperature(°C)

Figure 10 V_{GS(th)} vs Junction Temperature

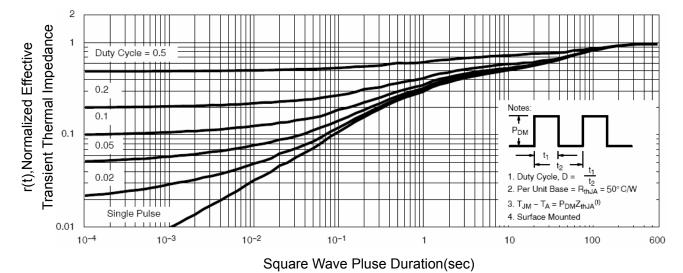


Figure 11 Normalized Maximum Transient Thermal Impedance

P-Channel Typical Electrical and Thermal Characteristics

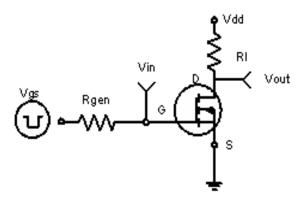


Figure 1:Switching Test Circuit

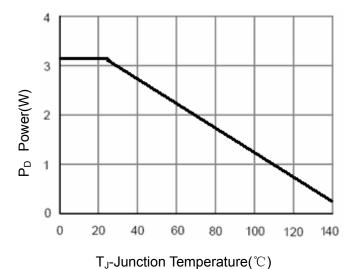


Figure 3 Power Dissipation

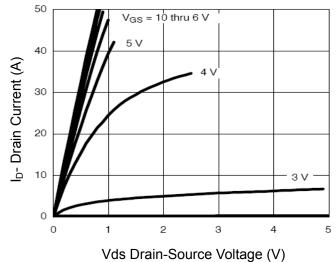


Figure 5 Output Characteristics

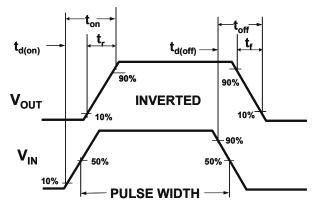


Figure 2:Switching Waveforms

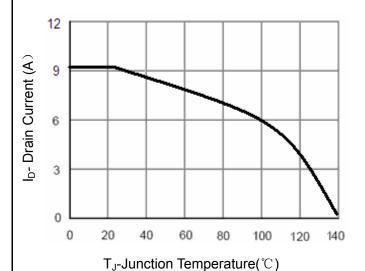


Figure 4 Drain Current

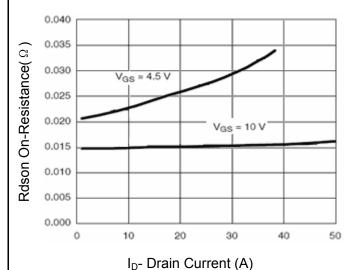


Figure 6 Drain-Source On-Resistance

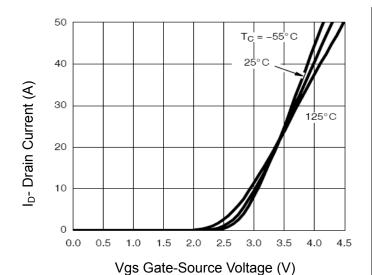
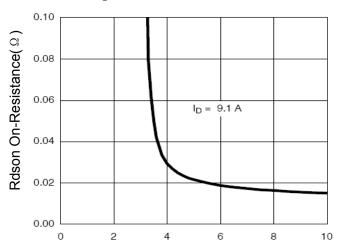


Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)

Figure 9 Rdson vs Vgs

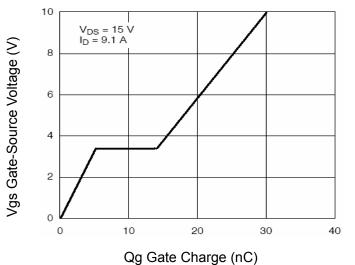


Figure 11 Gate Charge

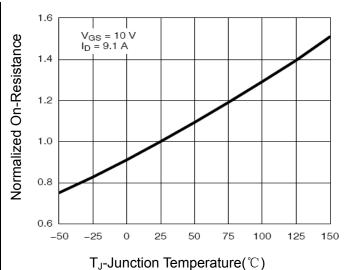
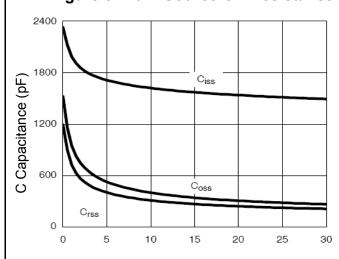


Figure 8 Drain-Source On-Resistance



Vds Drain-Source Voltage (V)

Figure 10 Capacitance vs Vds

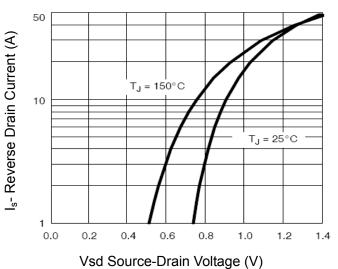
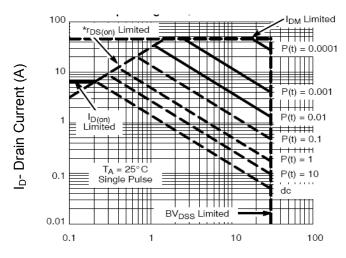


Figure 12 Source- Drain Diode Forward



Vds Drain-Source Voltage (V)

Figure 13 Safe Operation Area

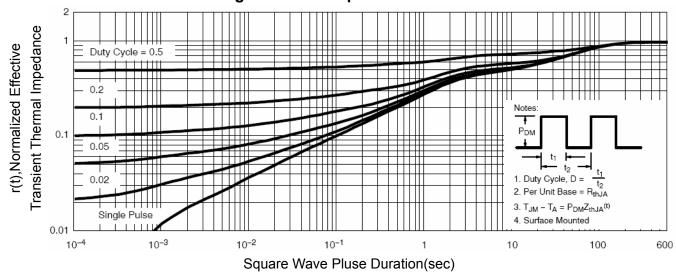
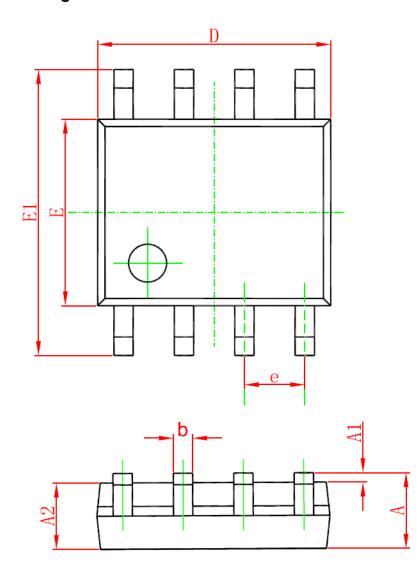
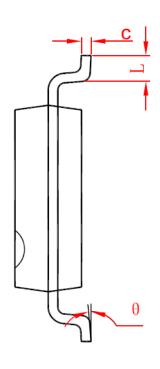
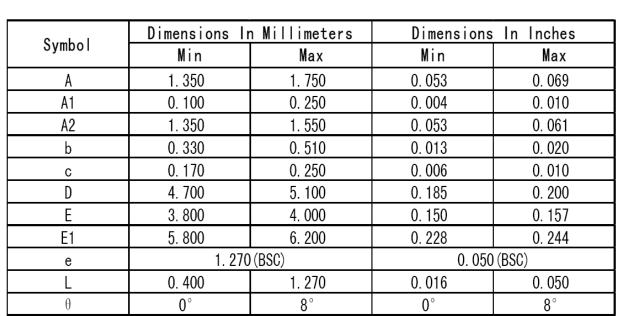


Figure 14 Normalized Maximum Transient Thermal Impedance

SOP-8 Package Information









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